


<b>Search Notes</b>  	<b>Application/Control No.</b>  10031085	<b>Applicant(s)/Patent Under Reexamination</b>  SHIRAISHI ET AL.
	<b>Examiner</b>  Kim, Kevin Y	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
375	329,326,331,332	2/5/07	kim
329	304,306	2/5/07	kim

SEARCH NOTES		
Search Notes	Date	Examiner
EAST keyword text search, see the printout	7/27/06	kim
update	2/5/07	kim

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
see interference search history			